

<b>Notice of References Cited</b>	Application/Control No. 10/601,124	Applicant(s)/Patent Under Reexamination CHEN, ZHONG-WEI	
	Examiner Jack I. Berman	Art Unit 2881	Page 1 of 1

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	L	US-			
	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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